



**ALPHA & OMEGA**  
SEMICONDUCTOR

**AON7406**

**30V N-Channel MOSFET**

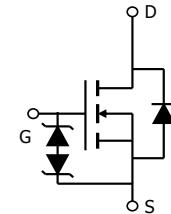
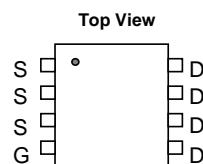
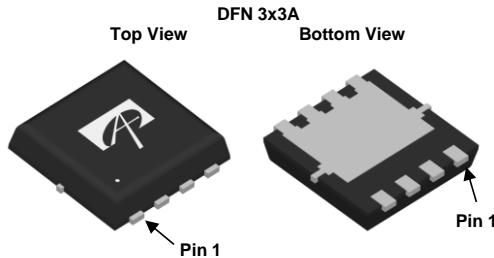
### General Description

- The AON7406 uses advanced trench technology and design to provide excellent  $R_{DS(ON)}$  with low gate charge. This device is suitable for use in SMPS and general purpose applications.
- RoHS and Halogen-Free Compliant

### Product Summary

$V_{DS}$	30V
$I_D$ (at $V_{GS}=10V$ )	25A
$R_{DS(ON)}$ (at $V_{GS}=10V$ )	< 17mΩ
$R_{DS(ON)}$ (at $V_{GS}=4.5V$ )	< 23mΩ
Typical ESD protection	HBM Class 2

100% UIS Tested  
100%  $R_g$  Tested



### Absolute Maximum Ratings $T_A=25^\circ C$ unless otherwise noted

Parameter	Symbol	Maximum	Units
Drain-Source Voltage	$V_{DS}$	30	V
Gate-Source Voltage	$V_{GS}$	$\pm 20$	V
Continuous Drain Current <sup>B</sup>	$I_D$	25	A
Continuous Drain Current <sup>C</sup>		15	
Pulsed Drain Current <sup>C</sup>	$I_{DM}$	50	A
Continuous Drain Current <sup>D</sup>	$I_{DSM}$	9	A
Continuous Drain Current <sup>E</sup>		7	
Avalanche Current <sup>C</sup>	$I_{AS}, I_{AR}$	19	A
Avalanche energy $L=0.1mH$ <sup>C</sup>	$E_{AS}, E_{AR}$	18	mJ
Power Dissipation <sup>B</sup>	$P_D$	15.5	W
Power Dissipation <sup>C</sup>		6	
Power Dissipation <sup>A</sup>	$P_{DSM}$	3.1	W
Power Dissipation <sup>E</sup>		2	
Junction and Storage Temperature Range	$T_J, T_{STG}$	-55 to 150	°C

### Thermal Characteristics

Parameter	Symbol	Typ	Max	Units
Maximum Junction-to-Ambient <sup>A</sup>	$R_{\theta JA}$	30	40	°C/W
Maximum Junction-to-Ambient <sup>D</sup>		60	75	°C/W
Maximum Junction-to-Case	$R_{\theta JC}$	6.6	8	°C/W

**Electrical Characteristics ( $T_J=25^\circ\text{C}$  unless otherwise noted)**

Symbol	Parameter	Conditions	Min	Typ	Max	Units
<b>STATIC PARAMETERS</b>						
$\text{BV}_{\text{DSS}}$	Drain-Source Breakdown Voltage	$I_D=250\mu\text{A}, V_{GS}=0\text{V}$	30			V
$\text{I}_{\text{DS}}^{\text{SS}}$	Zero Gate Voltage Drain Current	$V_{DS}=30\text{V}, V_{GS}=0\text{V}$ $T_J=55^\circ\text{C}$			1 5	$\mu\text{A}$
$\text{I}_{\text{GSS}}$	Gate-Body leakage current	$V_{DS}=0\text{V}, V_{GS}=\pm 16\text{V}$			10	$\mu\text{A}$
$\text{V}_{\text{GS(th)}}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=250\mu\text{A}$	1.2	1.8	2.4	V
$\text{I}_{\text{D(ON)}}$	On state drain current	$V_{GS}=10\text{V}, V_{DS}=5\text{V}$	50			A
$R_{\text{DS(ON)}}$	Static Drain-Source On-Resistance	$V_{GS}=10\text{V}, I_D=9\text{A}$ $T_J=125^\circ\text{C}$		14 20	17 24	$\text{m}\Omega$
		$V_{GS}=4.5\text{V}, I_D=8\text{A}$		18	23	$\text{m}\Omega$
$\text{g}_{\text{FS}}$	Forward Transconductance	$V_{DS}=5\text{V}, I_D=9\text{A}$		40		S
$\text{V}_{\text{SD}}$	Diode Forward Voltage	$I_S=1\text{A}, V_{GS}=0\text{V}$		0.75	1	V
$I_S$	Maximum Body-Diode Continuous Current				15	A
<b>DYNAMIC PARAMETERS</b>						
$C_{\text{iss}}$	Input Capacitance	$V_{GS}=0\text{V}, V_{DS}=15\text{V}, f=1\text{MHz}$	600	740	888	pF
$C_{\text{oss}}$	Output Capacitance		77	110	145	pF
$C_{\text{rss}}$	Reverse Transfer Capacitance		50	82	115	pF
$R_g$	Gate resistance	$V_{GS}=0\text{V}, V_{DS}=0\text{V}, f=1\text{MHz}$	0.5	1.1	1.7	$\Omega$
<b>SWITCHING PARAMETERS</b>						
$Q_g(10\text{V})$	Total Gate Charge	$V_{GS}=10\text{V}, V_{DS}=15\text{V}, I_D=9\text{A}$	12	15	18	nC
$Q_g(4.5\text{V})$	Total Gate Charge		6	7.5	9	nC
$Q_{gs}$	Gate Source Charge			2.5		nC
$Q_{gd}$	Gate Drain Charge			3		nC
$t_{D(\text{on})}$	Turn-On Delay Time	$V_{GS}=10\text{V}, V_{DS}=15\text{V}, R_L=1.67\Omega, R_{\text{GEN}}=3\Omega$		5		ns
$t_r$	Turn-On Rise Time			3.5		ns
$t_{D(\text{off})}$	Turn-Off Delay Time			19		ns
$t_f$	Turn-Off Fall Time			3.5		ns
$t_{rr}$	Body Diode Reverse Recovery Time	$I_F=9\text{A}, dI/dt=500\text{A}/\mu\text{s}$	6	8	10	ns
$Q_{rr}$	Body Diode Reverse Recovery Charge	$I_F=9\text{A}, dI/dt=500\text{A}/\mu\text{s}$	14	18	22	nC

A. The value of  $R_{\text{JJA}}$  is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^\circ\text{C}$ . The Power dissipation  $P_{\text{DSM}}$  is based on  $R_{\text{JJA}}$   $t \leqslant 10\text{s}$  value and the maximum allowed junction temperature of  $150^\circ\text{C}$ . The value in any given application depends on the user's specific board design.

B. The power dissipation  $P_D$  is based on  $T_{J(\text{MAX})}=150^\circ\text{C}$ , using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Repetitive rating, pulse width limited by junction temperature  $T_{J(\text{MAX})}=150^\circ\text{C}$ . Ratings are based on low frequency and duty cycles to keep initial  $T_J=25^\circ\text{C}$ .

D. The  $R_{\text{JJA}}$  is the sum of the thermal impedance from junction to case  $R_{\text{JJC}}$  and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300 $\mu\text{s}$  pulses, duty cycle 0.5% max.

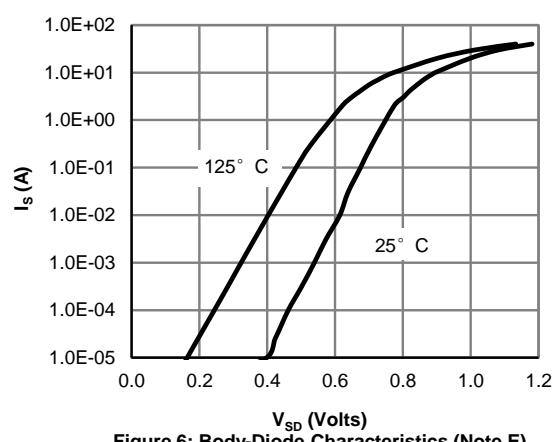
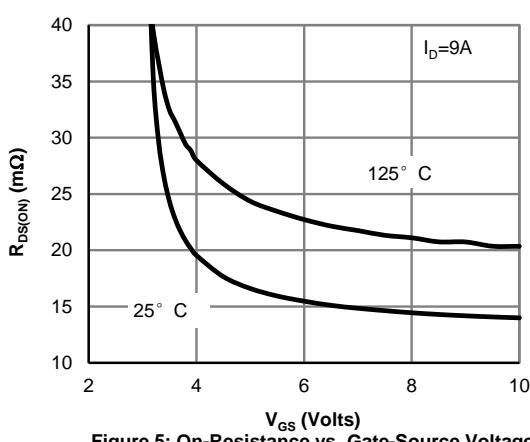
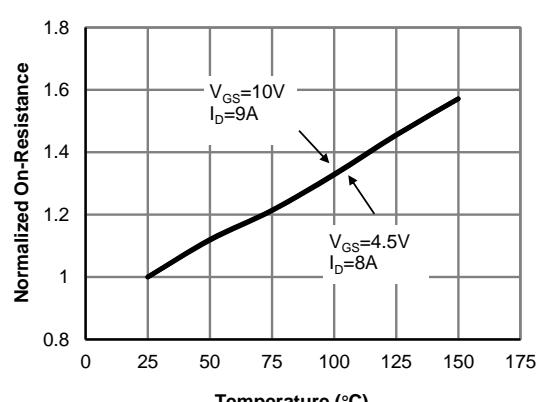
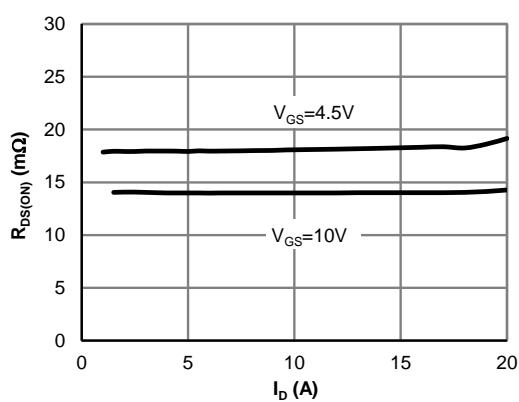
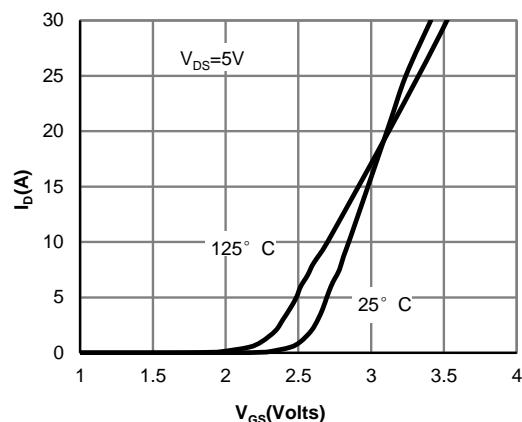
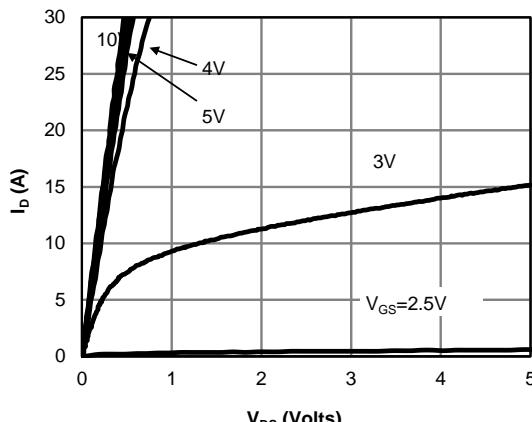
F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of  $T_{J(\text{MAX})}=150^\circ\text{C}$ . The SOA curve provides a single pulse rating.

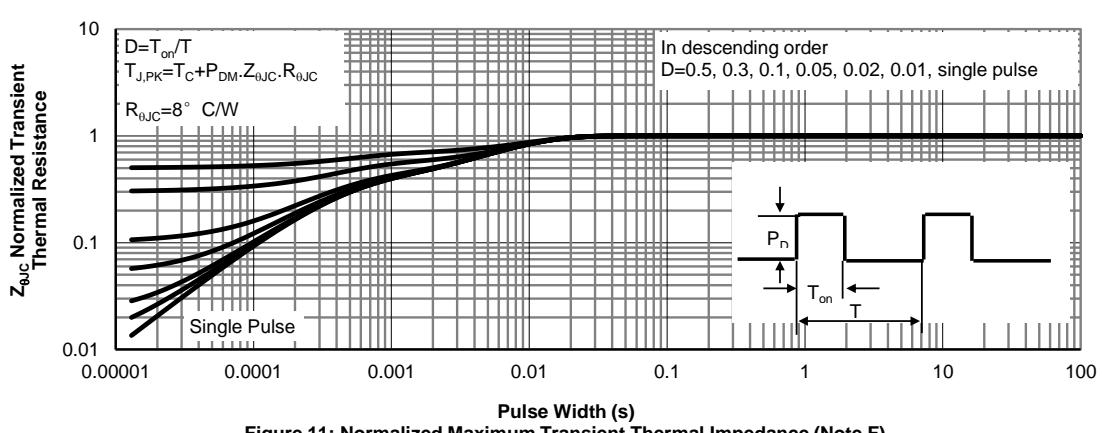
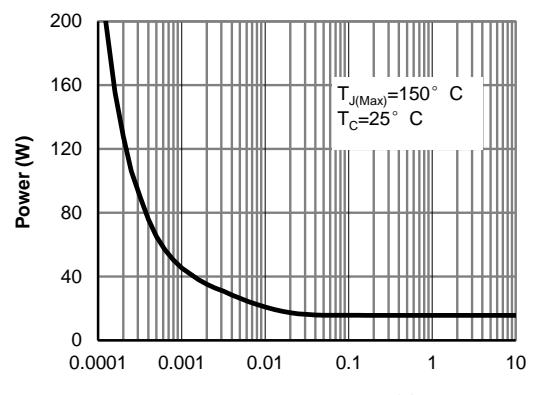
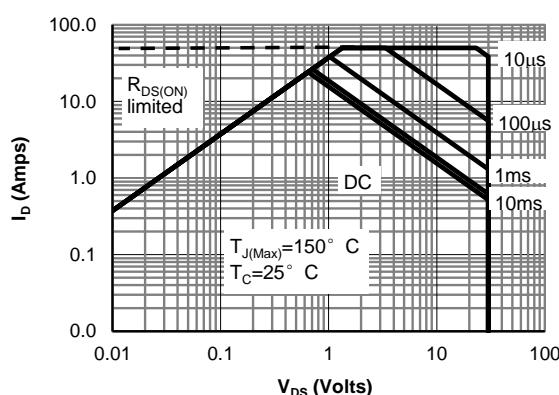
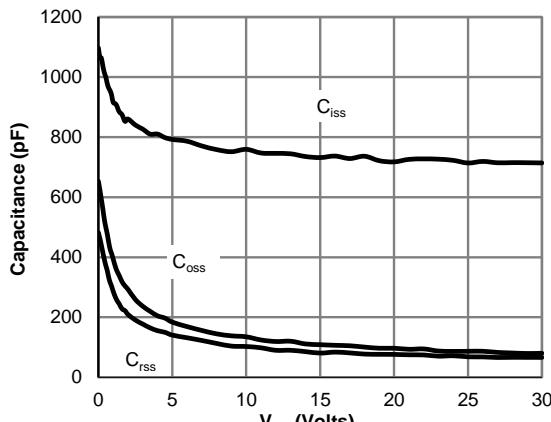
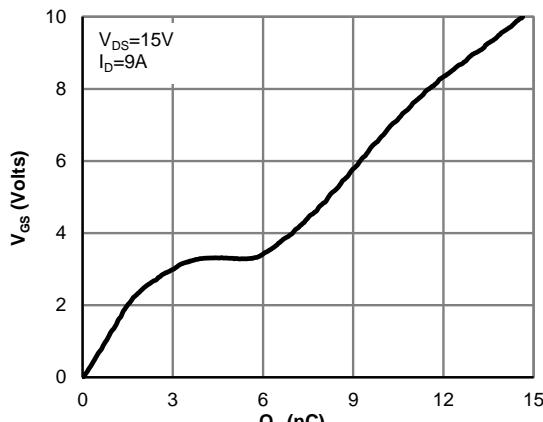
G. The maximum current rating is package limited.

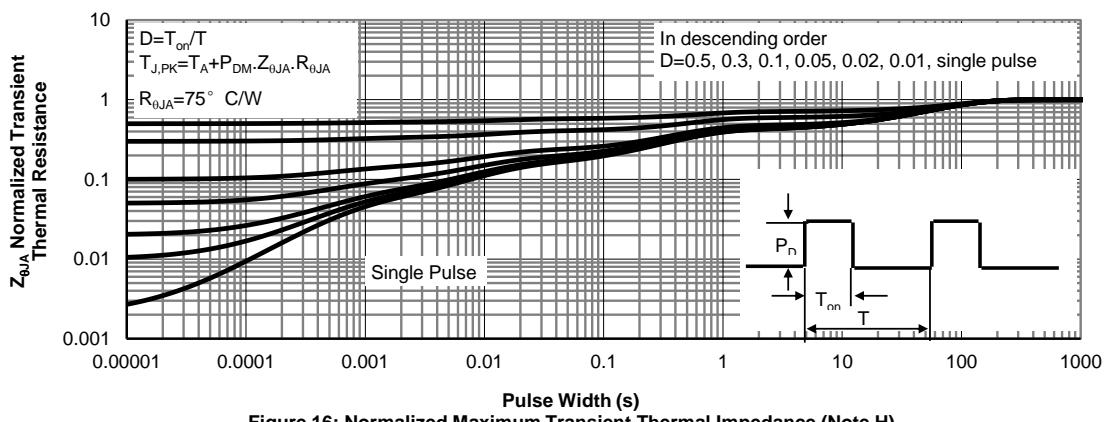
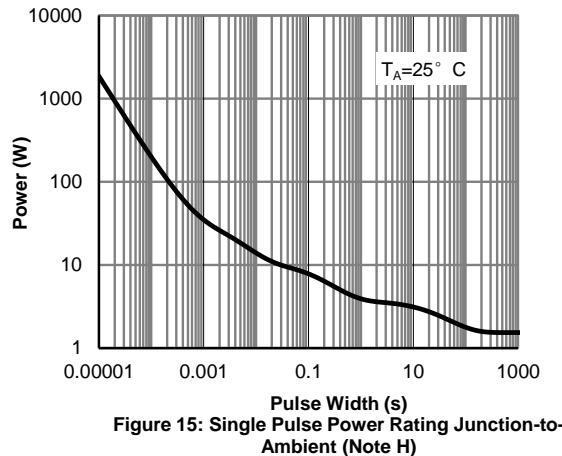
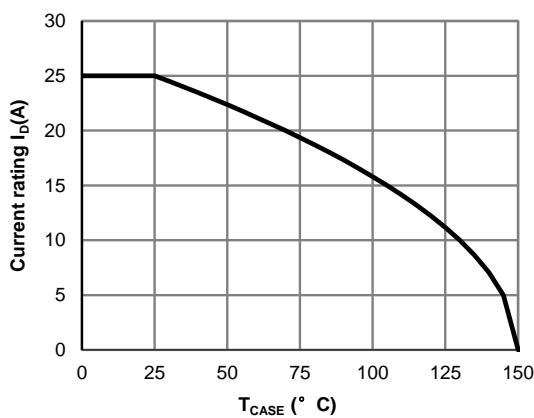
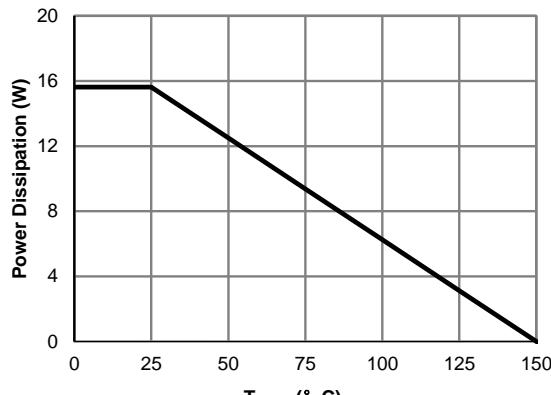
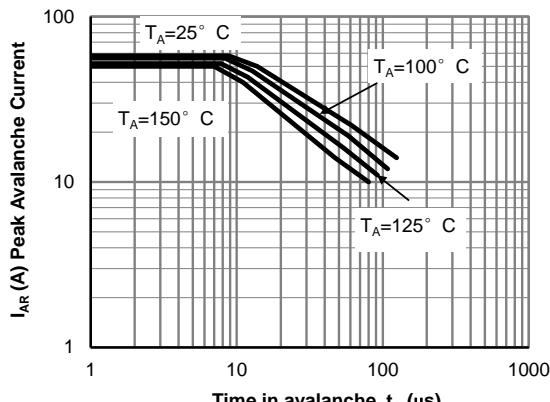
H. These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^\circ\text{C}$ .

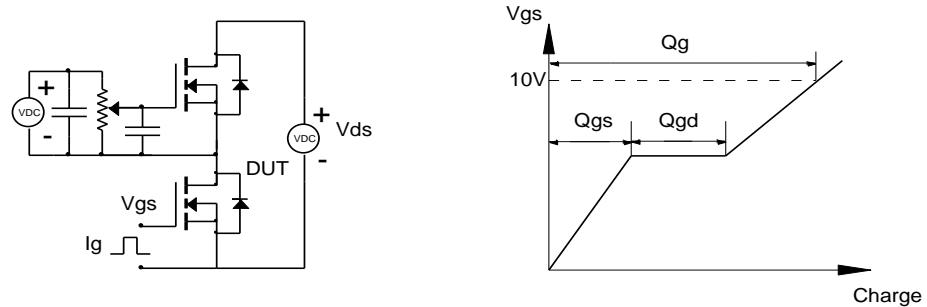
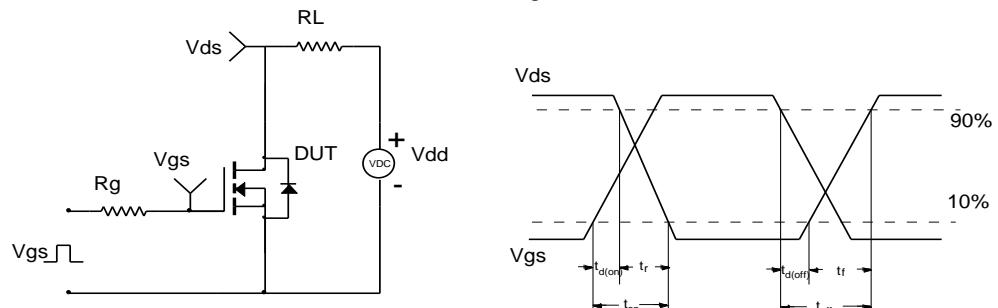
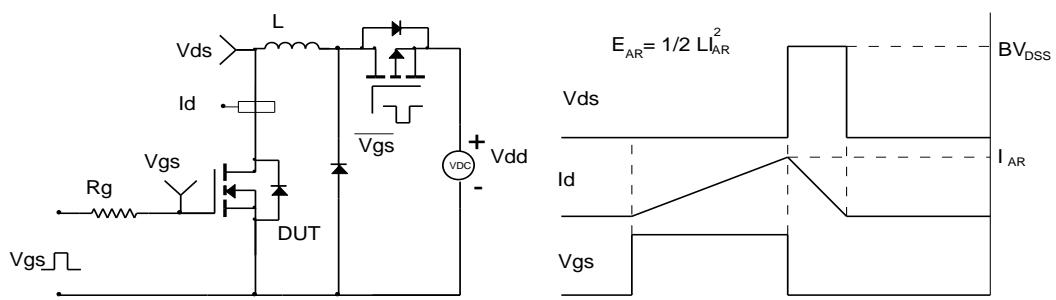
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